

<b>Notice of References Cited</b>	Application/Control No. 10/712,341		Applicant(s)/Patent Under Reexamination IWASAKI ET AL.	
	Examiner DANIEL TEKLE		Art Unit 2621	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,862,401	03-2005	Higashida et al.	386/100
*	B	US-2004/0126101	07-2004	Nakamura et al.	386/124
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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